



CE EMC TEST REPORT

Report No.: VTC-221213027E1

Product: Direct Attach Copper Twinax Cable

Model No.: ATDC-PP-10G-P/A-xM, See model list

Applicant: Approved Technology Ltd

Address: Wyncombe House, 2A Wyncombe Road, Southbourne,

Dorset, BH5 2JU, United Kingdom

Issued by: Shenzhen VTC Testing Technology Co., Ltd.

211 Factory Room, No. 96, Yangchong Road, Tangxiachong

Lab Location: Community, Yanluo Street, Bao'an District,

Shenzhen, Guangdong, China

Date of Receipt: Dec.07,2022 Date of Test:

Dec.07,2022 to Dec.13,2022

Date of Issue: Dec.13,2022

Test Result: Pass

<u>Testing Engineer</u>

(Jake Wang)

Technical Manager

(Ada Li)

Authorize Signatory

(Can Liu)

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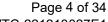
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TEST REPORT

Applicant : Approved Technology Ltd

Address : Wyncombe House, 2A Wyncombe Road, Southbourne, Dorset, BH5

2JU, United Kingdom

Manufacturer : Approved Technology Ltd

Address : Wyncombe House, 2A Wyncombe Road, Southbourne, Dorset, BH5

2JU, United Kingdom

EUT : Direct Attach Copper Twinax Cable

Model Number : ATDC-PP-10G-P/A-xM, ATDC-P28-25G-P/A-xM,

ATDC-QPP-40G-P/A-xM, ATDC-QPP-56G-P/A-xM,

ATDC-QPP-PP-10G-P/A-xM, ATDC-QP28-100G-P/A-xM, ATDC-QP56-200G-P/A-xM, ATDC-QPDD-400G-P/A-xM,

ATDC-QP28-4P28-100G-P/A-xM, ATDC-QPP-4PP-40G-P/A-xM

Trademark : ATGBICS

EN55032:2015+A1:2020+A11:2020

Test Standard : EN55035:2017+A11:2020

ENIEC61000-3-2:2019/A1:2021 EN61000-3-3:2013+A1:2019

Test Result: : Pass





1. GENERAL INFORMATION

1.1. Description of Device (EUT)

EUT : Direct Attach Copper Twinax Cable

Trademark : ATGBICS

Model Number : See model list

Model Difference : Apart from the name of the model, the others are the same

Power Supply : DC 3.3 V, 5V

Note:ATDC-PP-10G-P/A-xM was selected as the test model and the datas have been recorded in

this report.

1.2. Tested System Details

Personal Computer : ASUS

M/N: ATDC-PP-10G-P/A-xM

1.3. TEST SUMMARY

Conducted Emission : ±2.66dB

Uncertainty

Radiated Emission Uncertainty: ±4.26dB

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2. TEST INSTRUMENT USED

For Conducted Emission at the mains terminals Test

	Conducted Emission Test (A site)						
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
843 Shielded Room	ChengYu	843 Room	843	July.11, 2022	July.10, 2023		
EMI Receiver	R&S	ESCI	101421	July.11, 2022	July.10, 2023		
LISN	Schwarzbeck	NSLK8127	8127739	July.11, 2022	July.10, 2023		
Attenuator	R&S	ESH3-Z2	021E	July.11, 2022	July.10, 2023		
843 Cable 1#	FUJIKURA	843C1#	001	July.11, 2022	July.10, 2023		

For Conducted Emission at the telecom port Test

1 01 001144	To Conducted Emission at the telecom port Test						
	Conducted Emission Test (A site)						
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
843 Shielded Room	ChengYu	843 Room	843	July.11, 2022	July.10, 2023		
EMI Receiver	R&S	ESCI	101421	July.11, 2022	July.10, 2023		
Coupling/ Decoupling Network	PH	ISN T800	S1509001	July.11, 2022	July.10, 2023		
Attenuator	R&S	ESH3-Z2	021E	July.11, 2022	July.10, 2023		
843 Cable 1#	FUJIKURA	843C1#	001	July.11, 2022	July.10, 2023		

For Radiated Emission Test

Radiation Emission Test (966 chamber)						
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.	
966 chamber	ChengYu	966 Room	966	July.11, 2022	July.10, 2023	
Spectrum Analyzer	Agilent	E4407B	MY45109572	July.11, 2022	July.10, 2023	
Amplifier	Schwarzbeck	BBV9743	9743-119	July.11, 2022	July.10, 2023	
Amplifier	Schwarzbeck	BBV9718	9718-270	July.11, 2022	July.10, 2023	
Log-periodic Antenna	Schwarzbeck	VULB9160	VULB9160-3 369	July.11, 2022	July.10, 2023	
EMI Receiver	R&S	ESCI	101421	July.11, 2022	July.10, 2023	
Horn Antenna	Schwarzbeck	BBHA9120D	9120D-1275	July.11, 2022	July.10, 2023	
966 Cable 1#	CHENGYU	966	004	July.11, 2022	July.10, 2023	
966 Cable 2#	CHENGYU	966	003	July.11, 2022	July.10, 2023	

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For Harmonic & Flicker Test

For Harmonic / Flicker Test (A site)						
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.	
Harmonic / Flicker Analyzer	KIKUSUI	KHA1000	VA002445	July.11, 2022	July.10, 2023	
AC Power Supply	KIKUSUI	PCR4000M	UK001879	July.11, 2022	July.10, 2023	
Line Impedance network	KIKUSUI	LIN1020JF	UL001611	July.11, 2022	July.10, 2023	

For Electrostatic Discharge Immunity Test

For Electrostatic Discharge Immunity Test (A site)						
Equipment Manufacturer Model# Serial# Last Cal. Next Cal.						
ESD Tester KIKISUI KES4201A UH002321 July.11, 2022 July.10, 2023						

For RF Field Strength Susceptibility Test(SMQ)

	rental ried edengar edecepasmy reademax							
	For RF Field Strength Susceptibility Test (SMQ site)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.			
Signal Generator	HP	8648A	3625U00573	July.11, 2022	July.10, 2023			
Amplifier	A&R	500A100	17034	July.11, 2022	July.10, 2023			
Amplifier	A&R	100W/1000M1	17028	July.11, 2022	July.10, 2023			
Audio Analyzer (20Hz~1GHz)	Panasonic	2023B	202301/428	July.11, 2022	July.10, 2023			
Isotropic Field Probe	A&R	FP2000	16755	July.11, 2022	July.10, 2023			
Antenna	EMCO	3108	9507-2534	July.11, 2022	July.10, 2023			
Log-periodic Antenna	A&R	AT1080	16812	July.11, 2022	July.10, 2023			





For Electrical Fast Transient /Burst Immunity Test

For Electrical Fast Transient/Burst Immunity Test (A site)						
Equipment Manufacturer Model# Serial# Last Cal. Next Ca						
Burst Tester	Prima	EFT61004AG	PR14054467	July.11, 2022	July.10, 2023	
Coupling Clamp	Prima	EFT61004AG	009E	July.11, 2022	July.10, 2023	

For Surge Test

For Surge Test (A site)					
Equipment Manufacturer Model# Serial# Last Cal. Next C					Next Cal.
Surge Tester	Prima	SUG61005BX	PR12045446	July.11, 2022	July.10, 2023

For Injected Currents Susceptibility Test

For Injected Currents Susceptibility Test (A site)						
Equipment Manufacturer Model# Serial# Last Cal. Next Ca						
C/S Test System	SCHLODER	CDG600	126B1281	July.11, 2022	July.10, 2023	
CDN	SCHLODER	CDN-M2+3	A2210320/201 5	July.11, 2022	July.10, 2023	
Injection Clamp	SCHLOBER	EMCL-20	132A1214/201 5	July.11, 2022	July.10, 2023	

For Magnetic Field Immunity Test

For Magnetic Field Immunity Test (A site)					
Equipment Manufacturer Model# Serial# Last Cal. Next Cal.					
Magnetic field generator	HTEC	HPFMF	15701	July.11, 2022	July.10, 2023

For Voltage Dips Interruptions Test

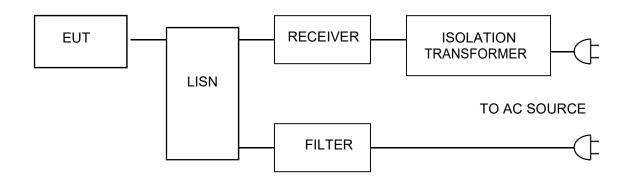
For Voltage Dips Interruptions Test (A site)					
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.
Dips Tester	Prima	DRP61011AG	PR14086284	July.11, 2022	July.10, 2023

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3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST

3.1. Block Diagram Of Test Setup



3.2. Test Standard

EN55032:2015+A1:2020+A11:2020

3.3. Power Line Conducted Emission Limit

Frequency	Limits dB(μ V)			
MHz	Quasi-peak Level	Average Level		
0.15 ~ 0.50	66 ~ 56*	56 ~ 46*		
0.50 ~ 5.00	56	46		
5.00 ~ 30.00	60	50		

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

3.4. EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN 55032 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

3.5. Operating Condition of EUT

- 3.5.1 Setup the EUT and simulators as shown in Section 3.1.
- 3.5.2 Turn on the power of all equipments.
- 3.5.3 Let the EUT work in test modes and test it.





3.6. Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the EN 55032 regulations during conducted emission test.

The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 10KHz.

The frequency range from 150 KHz to 30 MHz is investigated.

3.7. Test Result

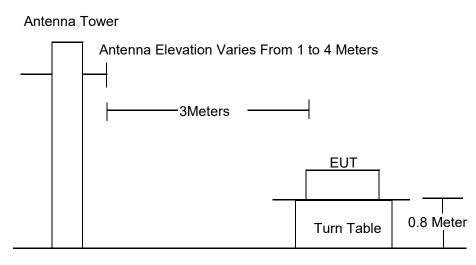
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4. RADIATION EMISSION TEST

4.1. Block Diagram of Test Setup



Ground Plane

4.2. Test Standard

EN55032:2015+A1:2020+A11:2020

4.3. Radiation Limit

Frequency Distance MHz (Meters)		Field Strengths Limits dB(μV)/m	Detector
30 ~ 230	3	40.0	QP
230 ~ 1000	3	47.0	QP
$1000\sim3000$	3	76.0	PEAK
$1000\sim3000$	3	56.0	AVERAGE
$3000\sim6000$	3	80.0	PEAK
$3000\sim6000$	3	60.0	AVERAGE

Remark:

- (1) Emission level (dB(μ V)/m) = 20 log Emission level (μ V/m)
- (2) The smaller limit shall apply at the cross point between two frequency bands.
- (3) Distance refers to the distance in meters between the measuring instrument, antenna and the closed point of any part of the device or system.



4.4. EUT Configuration on Test

The EN 55032 regulations test method must be used to find the maximum emission during radiated emission test.

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.2.

4.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.2 except the test set up replaced as Section 4.1.

4.6. Test Procedure

The EUT and its simulators are placed on a turned table that is 0.8 meter above the ground. The turned table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna that is mounted on the antenna tower. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level. Broadband antenna (calibrated biconical and log periodical antenna) is used as receiving antenna. Both horizontal and vertical polarization of the antenna is set on test. In order to find the maximum emission levels, the interface cable must be manipulated according to EN 55032 on radiated emission test.

The bandwidth setting on the field strength meter (R&S Test Receiver ESCI) is set at 120KHz below 1GHz, set at 1MHz above 1GHz

The frequency range from 30MHz to 1000MHz is checked.

The highest frequency of the internal sources of the EUT was below 108MHz, so the measurement was only made up to 1GHz.

4.7. Test Result

PASS

Please refer to the following page.





Radiation Emission Test Data

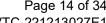
Temperature:
24.5 °C
Relative Humidity:
56%

Pressure:
1009hPa
Phase :
Horizontal

Test Voltage :
DC5V
Test Mode:
ON Mode



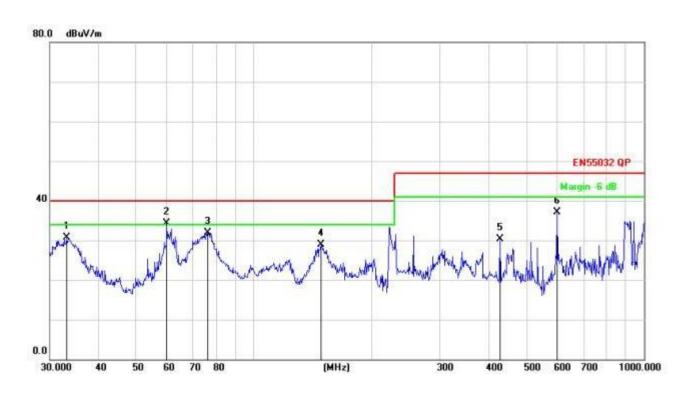
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector	cm	degree	Comment
1	1	61.3463	51.24	-15.86	35.38	40.00	-4.62	peak			
2	*	150.0108	56.29	-18.97	37.32	40.00	-2.68	peak			
3	1	222.1698	51.01	-16.16	34.85	40.00	-5.15	peak			
4		428.0193	48.24	-10.91	37.33	47.00	-9.67	peak			
5		599.3212	40.95	-6.74	34.21	47.00	-12.79	peak			
6		801.7863	36.33	-4.85	31.48	47.00	-15.52	peak			





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Radiation Emission Test Data				
Temperature:	24.5 ℃	Relative Humidity:	56%	
Pressure:	1009hPa	Phase :	Vertical	
Test Voltage :	DC5V	Test Mode:	ON Mode	



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector	cm	degree	Comment
1		33.2112	47.33	-16.61	30.72	40.00	-9.28	peak			
2	*	59.8588	49.83	-15.57	34.26	40.00	-5.74	peak			
3		76.2442	50.78	-18.86	31.92	40.00	-8.08	peak			
4	- 3	148.4410	48.01	-19.05	28.96	40.00	-11.04	peak			
5	15	428.0193	41.12	-10.91	30.21	47.00	-16.79	peak			
6	3	599.3212	43.80	-6.74	37.06	47.00	-9.94	peak			

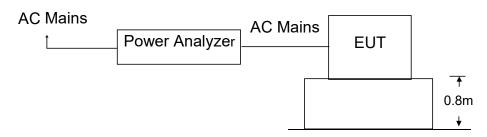
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5. HARMONIC CURRENT EMISSION TEST

5.1. Block Diagram of Test Setup



5.2. Test Standard

ENIEC61000-3-2:2019/A1:2021

5.3. Operating Condition of EUT

- 5.3.1 Setup the EUT as shown in Section 5.1.
- 5.3.2 Turn on the power of all equipments.
- 5.3.3 Let the EUT work in test mode and test it.

5.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

5.5. Test Results

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6. VOLTAGE FLUCTUATIONS & FLICKER TEST

6.1. Block Diagram of Test Setup

Same as Section 6.1..

6.2. Test Standard EN61000-3-3:2013+A1:2019 6.3. Operating Condition of EUT

Same as Section 5.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

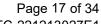
Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
dmax	4.0%
dt	Not exceed 3.3% for
	500ms

6.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

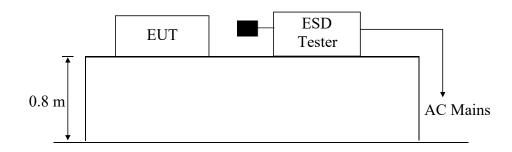
6.5. Test Results





7. ELECTROSTATIC DISCHARGE IMMUNITY TEST

7.1. Block Diagram of Test Setup



7.2. Test Standard

EN 55035:2017, EN 61000-4-2:2009

Severity Level: 3 / Air Discharge:±8KV Level: 2 / Contact Discharge:±4KV

7.3. Severity Levels and Performance Criterion

7.3.1 Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	±2	±2
2.	±4	±4
3.	±6	±8
4.	±8	±15
Х	Special	Special

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7.3.2 Performance criterion: B

A The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.

- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

7.4. EUT Configuration

The following equipments are installed on Electrostatic Discharge Immunity test to meet EN 55035:2017, EN 61000-4-2:2009, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 2.4.

7.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 3.5 except the test setup replaced by Section 7.1.2.

7.6. Test Procedure

7.6.1 Air Discharge:

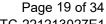
This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

7.6.2 Contact Discharge:

All the procedure shall be same as Section 7.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

7.6.3 Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular





to its front edge during the discharge.

7.6.4 Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are complete illuminated.

7.7. Test Results

PASS

Please refer to the following page.

ESD Test Data				
Temperature:	24.5℃	Humidity:	56%	
Power Supply :	DC5V	Test Mode:	On	

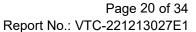
Air Discharge: ± 8KV

Contact Discharge: ± 4KV

For each point positive 25 times and negative 25 times discharge

Test Points	Air Discharge	Contact Discharge	Performance Criterion	Result
Enclosure	±2,4,8KV	N/A	В	PASS
Slit	N/A	N/A	В	PASS
Metal Part	N/A	±2,4 KV	В	PASS
VCP	N/A	±2,4 KV	В	PASS
HCP	N/A	±2,4 KV	В	PASS

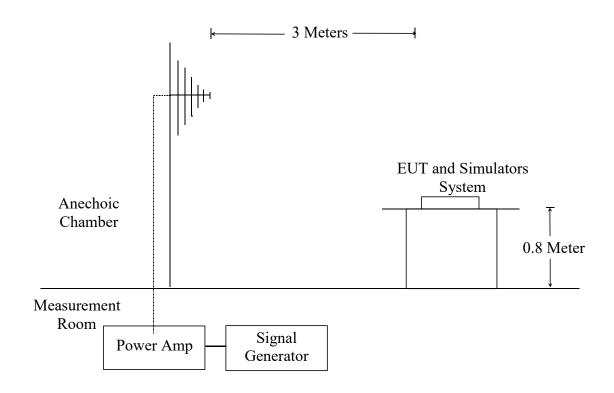
Note: N/A





8. RF FIELD STRENGTH SUSCEPTIBILITY TEST

8.1. Block Diagram of Test Setup



8.2. Test Standard

EN55035:2017+A11:2020 Severity Level 2, 3V / m

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8.3. Severity Levels and Performance Criterion

8.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X.	Special

8.3.2. Performance criterion: A

- A . The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C \ Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

8.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN55035:2017+A11:2020 , EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 3.4.

8.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.5 except the test setup replaced by Section 8.1.





8.6. Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

All the scanning conditions are as follows:

	Condition of Test	Remarks
1.	Fielded Strength	3 V/m (Severity Level 2)
2.	Radiated Signal	Modulated
3.	Scanning Frequency	80 – 1000 MHz
4.	Dwell time of radiated	0.0015 decade/s
5.	Waiting Time	1 Sec.

8.7. Test Results

PASS

Please refer to the following page.

		R/S Test	Data		
Temperature : 25℃			Humidity: 56%		
Field Strength: 3 V/m			Criterion: A		
Power Supply: DC5V			Frequency Range: 80 MHz to 1000 MHz		
Modulation:	☑ AM	☐ Pulse	□none	1 KHz	80%
Test Mode : On					
	Frequency Range : 80-1000MHz				
Steps	1 %				
		Horizontal	Vertical		Result
Front		А	А		Pass
Right		А	Α		Pass
Rear		А	А		Pass
Left		А	А		Pass
Note: N/A	•		•	•	

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9. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.1. Block Diagram of EUT Test Setup



9.2. Test Standard

EN55035:2017+A11:2020, EN 61000-4-4:2012

9.3. Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS Severity Level:

ocventy Level.				
Open Circuit Output Test Voltage ±10%				
On power ports	On I/O(Input/Output)			
	Signal data and control ports			
0.5KV	0.25KV			
1KV	0.5KV			
2KV	1KV			
4KV	2KV			
Special	Special			
	Open Circuit Output T On power ports 0.5KV 1KV 2KV 4KV			

Performance criterion: B

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.





9.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55035:2017, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 3.4.

9.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 9.1.

9.6. Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

9.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

9.7. Test Results

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10. SURGE TEST

10.1. Block Diagram of EUT Test Setup



10.2. Test Standard

EN55035:2017+A11:2020, EN61000-4-5:2014

10.3. Severity Levels and Performance Criterion

Severity Level: Line to Line, Level 2 at 1KV; Severity Level: Line to Earth, Level 3 at 2KV.

Severity Level	Open-Circuit Test Voltage (KV)	
1.	0.5	
2.	1.0	
3.	2.0	
4.	4.0	
X.	Special	

Performance criterion: B

- A The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.





10.4. EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN 55035:2017, EN61000-4-5:2014, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

10.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.7 except the test setup replaced by Section 10.1.

10.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 10.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.
- 6) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

10.7. Test Result

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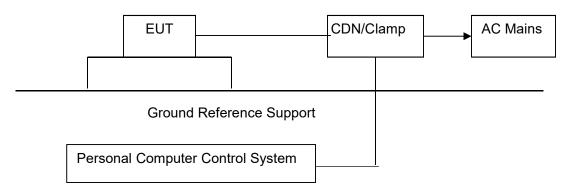
11. INJECTED CURRENTS SUSCEPTIBILITY TEST

11.1. Block Diagram of EUT Test Setup

11.1.1. Block Diagram of EUT Test Setup



11.1.2. Block Diagram of Test Setup



11.2. Test Standard

EN55035:2017+A11:2020, EN61000-4-6:2014

11.3. Severity Levels and Performance Criterion

Severity Level 2: 3V(rms), 150KHz $\sim \,$ 80MHz Severity Level:

Level	Field Strength V	
1.	1	
2.	3	
3.	10	
X.	Special	

Performance criterion: A

- A The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.





C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

11.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.8.

11.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.8 except the test set up replaced as Section 11.1.

11.6. Test Procedure

- 1) Set up the EUT, CDN and test generator as shown on section 11.1
- 2) Let EUT work in test mode and measure.
- 3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave
- 7) The rate of sweep shall not exceed 1.5×10⁻³ decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

11.7. Test Result

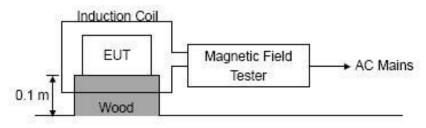
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12. AGNETIC FIELD IMMUNITY TEST

12.1. Block Diagram of Test Setup



Ground Reference Support

12.2. Test Standard

EN55035:2017+A11:2020 , EN61000-4-8:2010 Severity Level 1 at 1A/m

12.3. Severity Levels and Performance Criterion

12.3.1 Severity level

Level	Magnetic Field Strength A/m		
1.	1		
2.	3		
3.	10		
4.	30		
5.	100		
X.	Special		

12.3.2 Performance criterion: B

- A. The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

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12.4. EUT Configuration on Test

The configuration of EUT is listed in Section 2.9.

12.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.9 except the test set up replaced as Section 12.1.

12.6. Test Procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m*1m) and shown in Section 10.1. The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

12.7. Test Results

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13. VOLTAGE DIPS AND INTERRUPTIONS TEST

13.1. Block Diagram of EUT Test Setup



13.2. Test Standard

EN55035:2017+A11:2020, EN61000-4-11:2004

13.3. Severity Levels and Performance Criterion

Severity Level:

Input and Output AC Power Ports.

☑ Voltage Dips.

☑ Voltage Interruptions.

Environmental	Test Specification	Units	Performance	
Phenomena			Criterion	
Voltage Dips	>95	% Reduction	В	
	0.5	period		
	30	% Reduction	С	
	25	period		
Voltage	>95	% Reduction	0	
Interruptions	250	period	C	

Performance criterion: B, C, C

- A The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- C. Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

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13.4. EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.10.

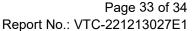
13.5. Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.10 except the test set up replaced as Section 13.1.

13.6. Test Procedure

- 1) Set up the EUT and test generator as shown on section 13.1
- 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.

13.7. Test Result





14. EUT PHOTOGRAPHS

EUT Photo 1

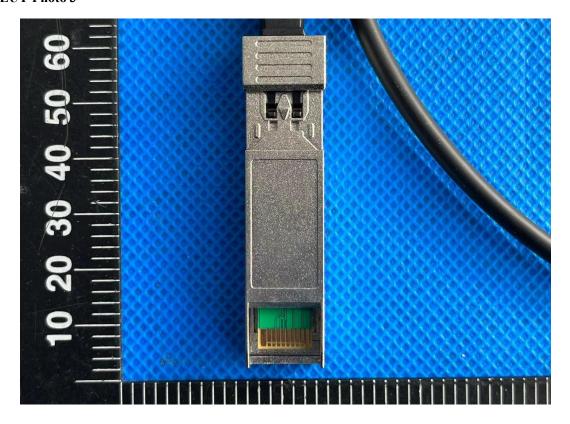


EUT Photo 2





EUT Photo 3



EUT Photo 4

